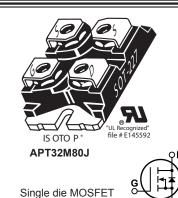




800V, 33A, 0.19Ω Max

N-Channel MOSFET

Power MOS 8 $^{\text{\tiny IM}}$ is a high speed, high voltage N-channel switch-mode power MOSFET. A proprietary planar strip design yields excellent reliability and manufacturability. Low switching loss is achieved with low input capacitance and ultra low $C_{\rm rss}$ "Miller" capacitance. The intrinsic gate resistance and capacitance of the poly-silicon gate structure help control slew rates during switching, resulting in low EMI and reliable paralleling, even when switching at very high frequency. Reliability in flyback, boost, forward, and other circuits is enhanced by the high avalanche energy capability.



FEATURES

- · Fast switching with low EMI/RFI
- Low R_{DS(on)}
- Ultra low C_{rss} for improved noise immunity
- · Low gate charge
- · Avalanche energy rated
- RoHS compliant

TYPICAL APPLICATIONS

- · PFC and other boost converter
- Buck converter
- Two switch forward (asymmetrical bridge)
- · Single switch forward
- Flyback
- Inverters

Absolute Maximum Ratings

Symbol	Parameter	Ratings	Unit
L	Continuous Drain Current @ T _C = 25°C	33	
D 'D	Continuous Drain Current @ T _C = 100°C	20	Α
I _{DM}	Pulsed Drain Current [⊕]	173	
V _{GS}	Gate-Source Voltage	±30	V
E _{AS}	Single Pulse Avalanche Energy ©	1979	mJ
I _{AR}	Avalanche Current, Repetitive or Non-Repetitive	24	Α

Thermal and Mechanical Characteristics

Symbol	Characteristic	Min	Тур	Max	Unit	
P _D	Total Power Dissipation @ T _C = 25°C			543	W	
R _{eJC}	Junction to Case Thermal Resistance			0.23	°C/W	
R _{ecs}	Case to Sink Thermal Resistance, Flat, Greased Surface		0.15		1 0/00	
T _J ,T _{STG}	Operating and Storage Junction Temperature Range	-55		150	°C	
V _{Isolation}	RMS Voltage (50-60hHz Sinusoidal Wavefomr from Terminals to Mounting Base for 1 Min.)	2500			V	
W _T	Deduces Weight		1.03		OZ	
	Package Weight		29.2		g	
Torque	Terminals and Mounting Screws.			10	in·lbf	
				1.1	N·m	

Static Characteristics

T_J = 25°C unless otherwise specified

Α	P1	Г3	21	VI.	8	n.	J

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
V _{BR(DSS)}	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_{D} = 250\mu$	A 800			V
$\Delta V_{BR(DSS)}/\Delta T_{J}$	Breakdown Voltage Temperature Coefficient	Reference to 25°C, $I_D = 2$	50µA	1.41		V/°C
R _{DS(on)}	Drain-Source On Resistance ^③	V _{GS} = 10V, I _D =24A	,	0.16	0.19	Ω
V _{GS(th)}	Gate-Source Threshold Voltage	\/ -\/ -25m	3	4	5	V
$\Delta V_{GS(th)}/\Delta T_{J}$	Threshold Voltage Temperature Coefficient	$V_{GS} = V_{DS}, I_D = 2.5 m$	IA	-10		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 800V$ $T_{J} = 25^{\circ}$	С		100	μA
		$V_{GS} = 0V$ $T_J = 125$	°C		500	μΑ
I _{GSS}	Gate-Source Leakage Current	V _{GS} = ±30V			±100	nA

Dvnamic Characteristics

T₁ = 25°C unless otherwise specified

Dynamic C	ilaracteristics ij = 25	20 o umess otherwise specimen					
Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit	
9 _{fs}	Forward Transconductance	V _{DS} = 50V, I _D = 24A		43		S	
C _{iss}	Input Capacitance	V 0V V 05V		9326			
C _{rss}	Reverse Transfer Capacitance	$V_{GS} = 0V, V_{DS} = 25V$ f = 1MHz		159			
C _{oss}	Output Capacitance	2		927			
C _{o(cr)} ④	Effective Output Capacitance, Charge Related	V = 0V V = 0V to 522V		438		pF	
C _{o(er)} ⑤	Effective Output Capacitance, Energy Related	V _{GS} = 0V, V _{DS} = 0V to 533V		217			
Q _g	Total Gate Charge	V 01: 40V 1 044		303			
Q _{gs}	Gate-Source Charge	$V_{GS} = 0 \text{ to } 10V, I_{D} = 24A,$ $V_{DS} = 400V$		51		nC	
Q_{gd}	Gate-Drain Charge	V _{DS} = 400V		155			
t _{d(on)}	Turn-On Delay Time	Resistive Switching		53			
t _r	Current Rise Time	V _{DD} = 533V, I _D = 24A		76		ne	
t _{d(off)}	Turn-Off Delay Time	$R_{G} = 2.2\Omega^{\textcircled{6}}, V_{GG} = 15V$		231		ns	
t _f	Current Fall Time			67			

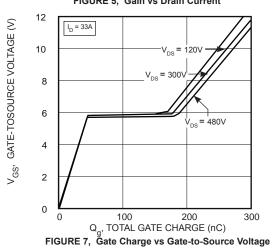
Source-Drain Diode Characteristics

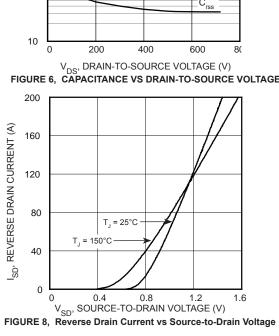
Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
I _s	Continuous Source Current (Body Diode)	MOSFET symbol showing the integral reverse p-n			32	A
I _{SM}	Pulsed Source Current (Body Diode) ^①	integral reverse p-n junction diode (body diode)			173	A
V _{SD}	Diode Forward Voltage	I _{SD} = 24A, T _J = 25°C, V _{GS} = 0V			1.0	V
t _{rr}	Reverse Recovery Time	I _{SD} = 24A, V _{DD} = 100V ^③		1000		ns
Q _{rr}	Reverse Recovery Charge	$di_{SD}/dt = 100A/\mu s$, $T_J = 25^{\circ}C$		20		μC
dv/dt	Peak Recovery dv/dt	I _{SD} ≤ 24A, di/dt ≤1000A/μs, V _{DD} = 100V, T _J = 125°C			10	V/ns

- (1) Repetitive Rating: Pulse width and case temperature limited by maximum junction temperature.
- ② Starting at $T_J = 25$ °C, L = 6.9mH, $R_G = 25\Omega$, $I_{AS} = 24A$.
- \bigcirc Pulse test: Pulse Width < 380 μ s, duty cycle < 2%.

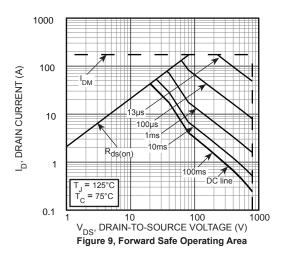
- (6) R_G is external gate resistance, not including internal gate resistance or gate driver impedance. (MIC4452)

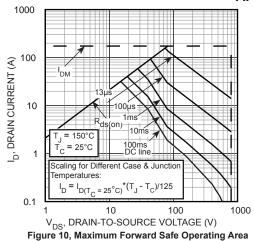
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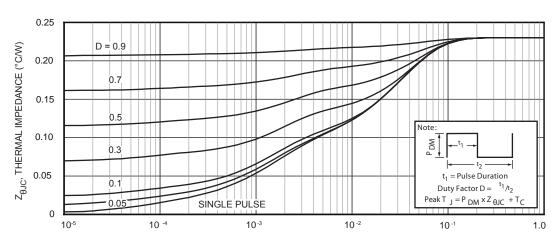




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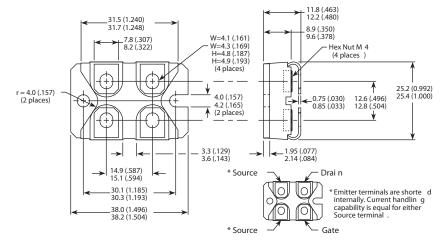






RECTANGULAR PULSE DURATION (seconds)
Figure 11. Maximum Effective Transient Thermal Impedance Junction-to-Case vs Pulse Duration

SOT-227 (ISOTOP®) Package Outline



Dimensions in Millimeters (Inches)

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25.163.2453	0 25.163.4253.0	25.190.2053.0	25.194.3453.0	25.320.4853.1	25.320.5253.1	25.326.3253.1	25.326.3553.1	25.330.1653.1
25.330.4753	1 25.330.5253.1	25.334.3253.1	25.334.3353.1	25.350.2053.0	25.352.4753.1	25.522.3253.0	<u>T483C</u> <u>T484C</u>	<u>T485F</u> <u>T485H</u>
T512F-YEB	<u>T513F</u> <u>T514F</u>	T554 T612FSE	25.161.3453.0	25.179.2253.0	25.194.3253.0	25.325.1253.1	25.326.4253.1	25.330.0953.1
25.332.4353.	1 25.350.1653.0	25.350.2453.0	25.352.1453.0	25.352.1653.0	25.352.2453.0	25.352.5453.1	25.522.3353.0	25.602.4053.0
25.640.5053.	0							